


<b>Search Notes</b>  	<b>Application/Control No.</b>  10719070	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  Tang, Kenneth	<b>Art Unit</b>  2195

SEARCHED			
Class	Subclass	Date	Examiner
718	100, 102-105	1/5/08	KT
714	6	1/5/08	KT
711	141	1/5/08	KT

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, text search	1/5/08	KT
Google Scholar and Altavista Internet NPL search	1/5/08	KT
IEEE Xplore NPL Search	1/5/08	KT
Inventor search in PALM/EAST	1/5/08	KT
IP.com NPL Concept Search on the Abstract	1/5/08	KT

INTERFERENCE SEARCH			
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